

Search Notes



Application/Control No.

10/670,758

Examiner

Anh V. La

Applicant(s)/Patent under Reexamination

CHUN ET AL.

Art Unit

2636

SEARCHED

Class	Subclass	Date	Examiner
340	544	6/24/05	AL
	550		
	545.2		
	556		
	522		
	521		
	565		
	429		
	545.1		
	540		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
PLUS	3/29/05	AL